

PERFORMANCE TEST REPORT

NV300-1LS64-AMB

S/N: SR202507100101

Product	Mechanical	System	Test
Manager	Engineer	Engineer	Engineer
Honwen Huang	Fulin Chuang	William Cheng	

Date: November 19, 2025







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1. SPECIFICATION

1-1. System Configuration

Motherboard	AGX Orin for DSBOARD-AGXMAX Board Serial Number: 1425124333971 BIOS Firmware Version: 36.3.0-gcid-36191598
CPU	Product: ARMv8 Model name: Cortex-A78AE CPU max (MHz): 2201.6 MHz
Memory	64GB 256-bit LPDDR5 204.8GB/s
Storage	64GB eMMC 5.1
GPU	2048-core NVIDIA Ampere architecture GPU with 64 Tensor Cores GPU Max Frequency: 1.3 GHz

1-2. PRODUCT INTERIOR PHOTO



2. TEST PLAN

2-1. THERMAL MEASUREMENT PROCESS

Test Purpose	The purpose of conducting thermal profile testing is to identify potential thermal issues in the Equipment Under Test (EUT). Given that semiconductor failure rates increase significantly with rising junction temperatures, this testing contributes to the overall assessment of product reliability. As the system undergoes a cooling phase, operational modes may shift depending on stack configuration, temperature, and heat dissipation characteristics. Thermal mapping provides critical insight for optimizing thermal management strategies and determining the most effective component layout and monitoring arrangements.
Test Equipment	1. KSON THS-B4T-150 Chamber.
Quantity Tested	Minimum 1 Set
Test Software	CPU Stress: Stress-ng GPU Stress: glmark2 LAN Speed Test: iPerf3
Test Procedure	 Thermal Pre-Scan Measurement: Temperature Range: -20°C to 60°C Humidity Condition: 60% RH (when temperature exceeds 25°C) Actual Thermal Measurement Procedure: Identify the test points using the infrared thermal image and attach thermocouples to the identified hot spots. Place the Equipment Under Test (EUT) in the thermal chamber and configure the test temperature profile according to the specified requirements. Power on the EUT after closing the thermal chamber. Boot into Ubuntu 22.04.5 LTS and initiate a maximum power consumption and stress test. After running the test software continuously for 8 hours, record the peak temperature observed at each thermocouple measurement point. Power off both the thermal chamber and the EUT. Verify that the recorded temperature data for each component remains within its specified operating temperature range, as defined in the component specification or approval documents.
Test Diagram of Curves	Environment defines for 53 hours. Temp. (°C) Temperature testing period Humidity (%) 90% 85% 60% 40% 20% 0% Time (hour)

2-2. TEST RESULT

2-2-1. Temperature Cycle

Aging tests were performed on individual components across a range of temperature settings, under both maximum load and full load conditions, to evaluate thermal endurance and operational stability over time.

Test Temperature	Test Result
-20°C / 0%RH	PASS PASS
0°C / 0%RH	PASS
25°C / 60%RH	PASS
40°C / 60%RH	PASS
50°C / 60%RH	PASS
60°C / 60%RH	PAS5

PERFORMANCE TEST REPORT

NV300-1LS64-AMB

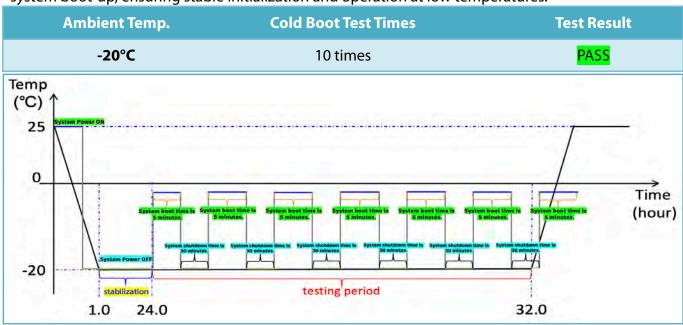
2-2-2. I/O Function

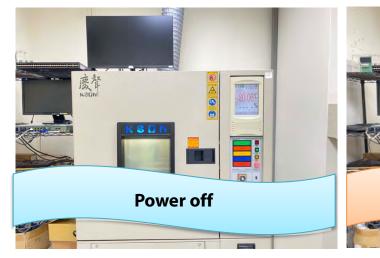
Confirm that the system specifications and all input/output (I/O) interfaces are correctly configured and functioning as intended, in accordance with the defined technical standards.

Item	Test Criteria					
X2 – HDMI	June 10 Ju					
X3 – USB 3.0	A PassMark USB 3.0 Loopback was connected for testing and was found to be functioning normally.					
X4 – 1.0GbE	tested. The transfer speed meets the required standard with zero					
X5 – RS422	he two RS422 devices were successfully connected. Data transmission tests showed no packet loss, confirming normal operation.	PASS				

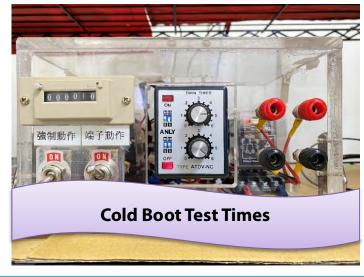
2-2-3. Low Temperature Power Cycle Test

Apply power to the system under a -20°C ambient condition and confirm successful system boot-up, ensuring stable initialization and operation at low temperatures.





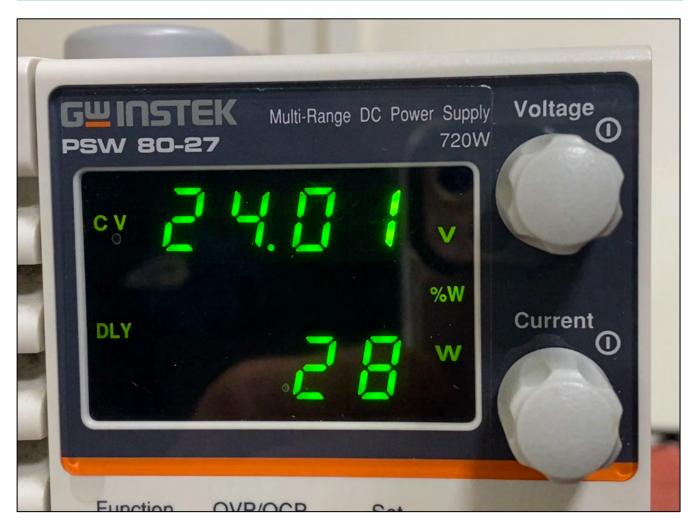




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2-3. POWER CONSUMPTION

Voltage	Current	Wattage
12.0V	2.33A	28W
24.0V	1.67A	28W
30.0V	0.93A	28W



3. TEST PHOTO IN LAB





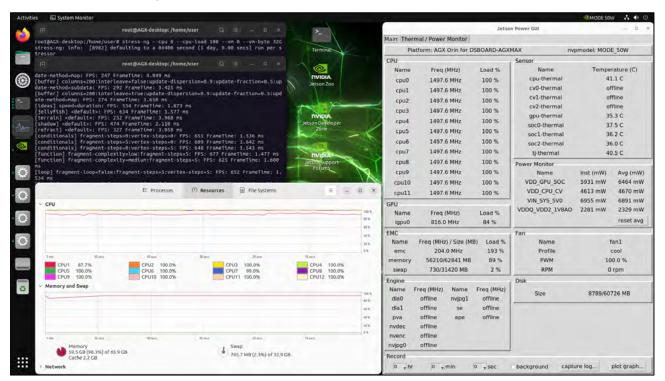


- Chamber in 0°C / 0%RH





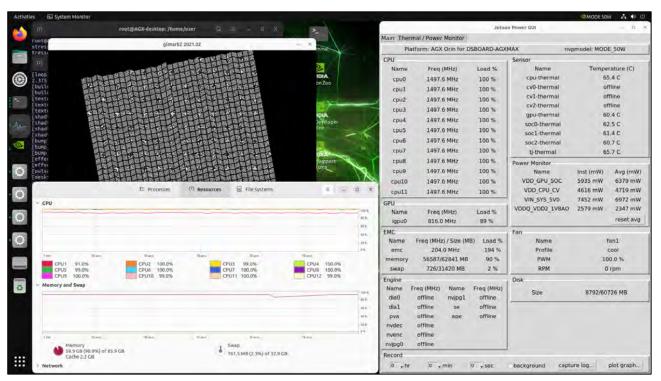
- Chamber in 25°C / 60%RH





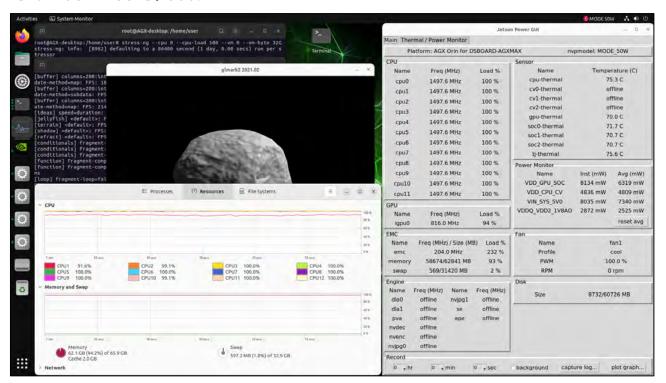
- Chamber in 40°C / 60%RH Main Thermal / Power Monitor Platform: AGX Orin for DSBOARD-AGXMAX nypmodel: MODE 50W Name Load % Name Freq (MHz) 1497.6 MHz 100 % cpu0 cv0-thermal offline 1497.6 MHz cpu1 1497.6 MHz 100 % cv2-thermal сриз 1497.6 MHz 100 % gpu-thermal soc0-thermal 49.6 C 51.5 C 1497.6 MHz cpu4 100 % 1497.6 MHz 100 % 50.7 C 50.6 C soc1-thermal сриб 1497.6 MHz 100 % soc2-thermal 1497.6 MHz cpu7 100 % tj-thermal 55.4 C cpu8 100 % 1497.6 MHz 100 % VDD GPU SOC 5931 mW 6418 mW 5272 mW 4708 mW cpu10 1497.6 MHz 100 % VDD_CPU_CV 1497.6 MHz cpul1 100 % VIN SYS 5VO 6855 mW 6901 mW CPU GPU VDDQ_VDD2_1V8AO 2182 mW 2316 mW Freq (MHz) Load % reset avg igpu0 816.0 MHz 85 % Name Freg (MHz) / Size (MB) Load % Name fan1 cool 100.0 % 51112/62841 MB PWM 81 % 729/31420 MB Memory and Swap Freq (MHz) 8790/60726 MB Size dia0 dia1 offline offline nvjpg1 pva nvdec offline nvenc offline nvjpg0 Memory 54.2 GB (82.3%) of 65.9 GB Cache 2.2 GB 5wap 764.7 MB (2.3%) of 32.9 GB ::: background capture log... plot graph... 農聲KSON 4 (0

- Chamber in 50°C / 60%RH





- Chamber in 60°C / 60%RH





4. THERMAL TEST RESULT(-20°C ~ +60°C)

CPU & GPU Temperature/Frequency

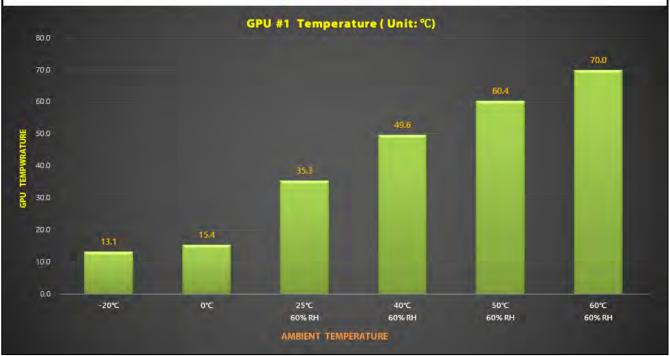
Temperature Ambient Temp.	-20°C	0°C	25°C 60% RH	40°C 60% RH	50℃ 60% RH	60℃ 60% RH
CPU Cores Max Temperature (Unit: °C)	20.7	20.8	41.1	55.4	65.4	75.3
CPU Cores Frequency (Unit: MHz)	1497.60	1497.60	1497.60	1497.60	1497.60	1497.60
Temperature Ambient Temp.	-20℃	0°℃	25℃ 60% RH	40°C 60% RH	50℃ 60% RH	60℃ 60% RH
GPU Temperature (Unit: °C)	13.1	15.4	35.3	49.6	60.4	70.0
	10000	I and a	816.0	816.0	816.0	816.0

ore Temp		Ambient Temp	-20°C	0°C	25°C 60% RH	40°C 60% RH	50℃ 60% RH	60°C 60% RH
CPU Core	s Max Temp	erature (Unit: °C)	20.7	20.8	41.1	55.4	65.4	75.3
20.0	777	СР	U Temperat	ure (Unit	:: °C)		1.0	
80.0							75.	3
70.0						65.4		
60.0				55	.4		_	
≝ 50.0								
CPU TEMPWRATURE 40.0			41.1				_	
TEM						•	_	
₹ 30.0	20.7	20.8						
20.0							_	
10.0								
0.0	-20°C	0°C	25°C	40	90	50°C	60°	
	-20 G	0.0	60% RH	50%		60% RH	60%	

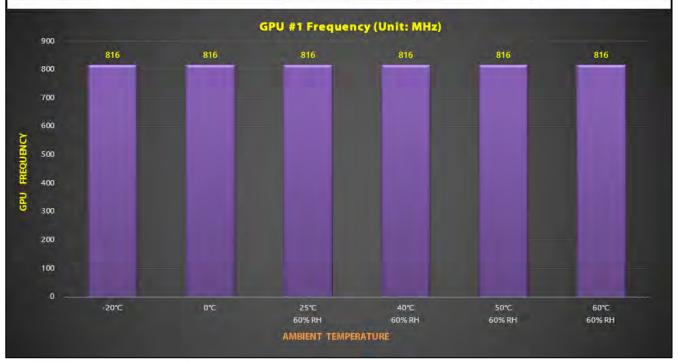
AMBIENT TEMPERATURE



Core Temp Ambient Temp CPU Frequency	-20°C	0°C	25°C 60% RH	40°C 60% RH	50°C 60% RH	60°C 60% RH
GPU #1 Temperature (Unit: °C)	13.1	15.4	35.3	49.6	60.4	70.0

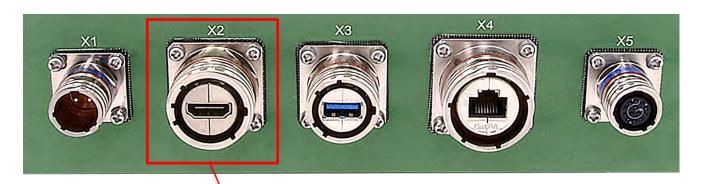


Core Temp CPU Frequency	-20°C	0°℃	25°C 60% RH	40℃ 60% RH	50°C 60% RH	60°C 60% RH
GPU #1 Frequency (Unit: MHz)	816	816	816	816	816	816

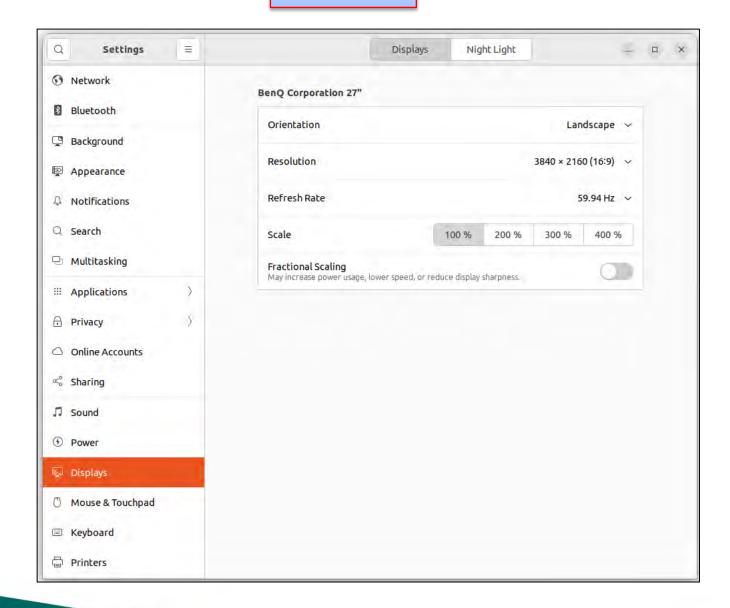


5. I/O FUNCTION TEST

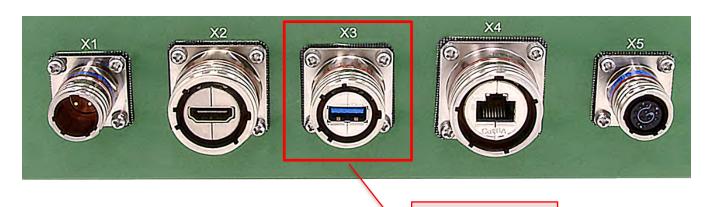
5-1. HDMI PORT



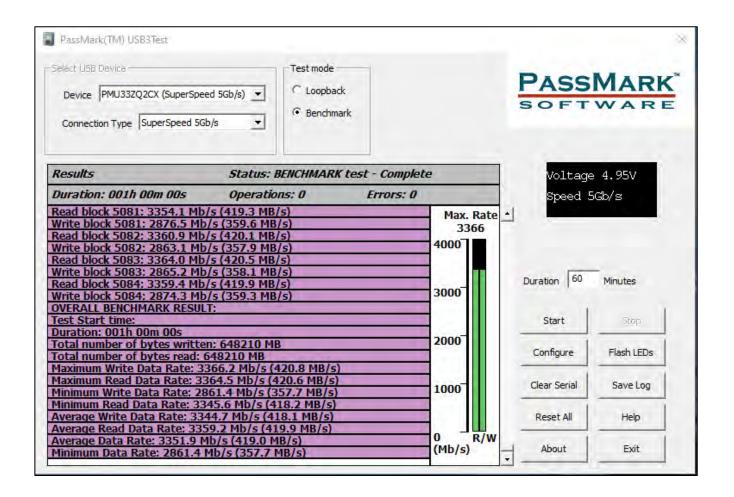
HDMI



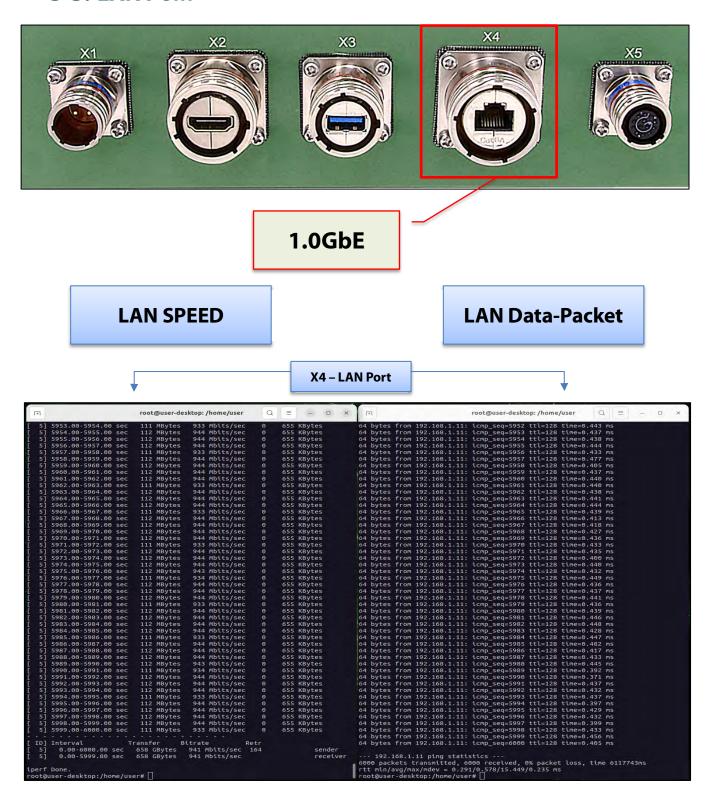
5-2. USB PORT



USB 3.0



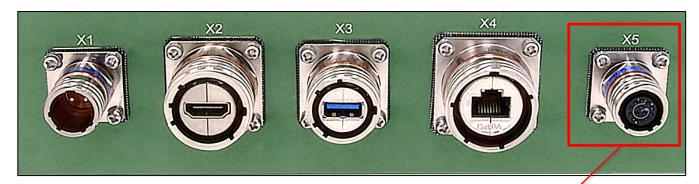
5-3. LAN PORT



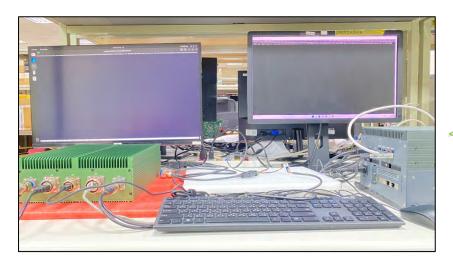
LAN Speed Test Result: Pass

LAN Data-Packet Test Result: 0 Lost (0% loss)

5-4. SERIAL PORT & USB PORT



This port provides RS-422 data transmission and the device's USB interface for the display connection.



RS-422 data transmission



The USB interface is used to transmit the side-panel function-key signals of the display.

----END-----



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S/N: SR202507100102

Product Manager			Test Engineer		
Honwen Huang	Fulin Chuang	William Cheng	Mike Chen		

Date: November 19, 2025







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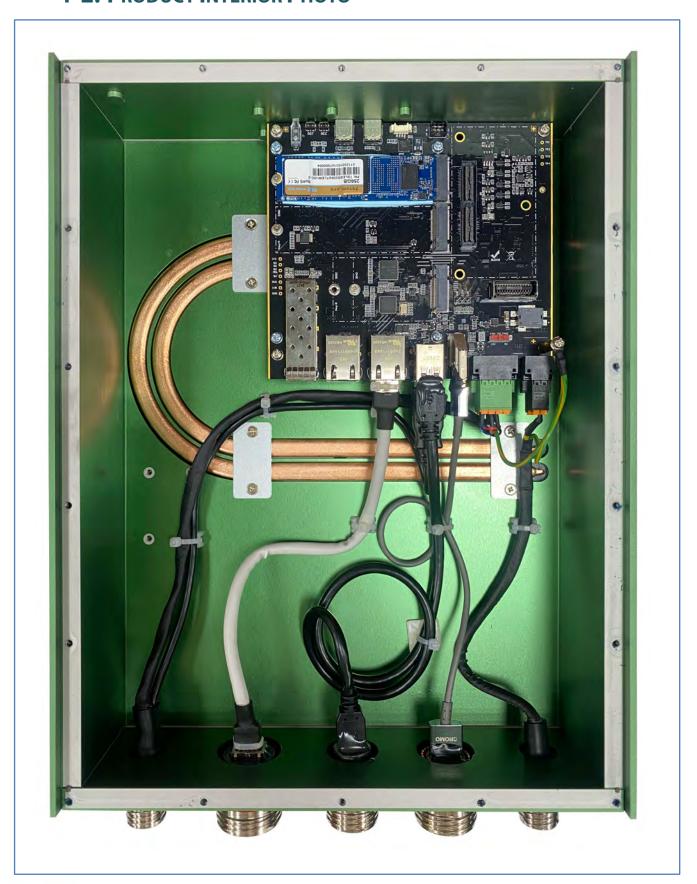
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CPU	Product: ARMv8 Model name: Cortex-A78AE CPU max (MHz): 2201.6 MHz
Memory	64GB 256-bit LPDDR5 204.8GB/s
Storage	64GB eMMC 5.1
GPU	2048-core NVIDIA Ampere architecture GPU with 64 Tensor Cores GPU Max Frequency: 1.3 GHz

1-2. PRODUCT INTERIOR PHOTO



2. TEST PLAN

2-1. THERMAL MEASUREMENT PROCESS

The purpose of conducting thermal profile testing is to identify potential thermal in the Equipment Under Test (EUT). Given that semiconductor failure rates in significantly with rising junction temperatures, this testing contributes to the assessment of product reliability. As the system undergoes a cooling phase, operational modes may shift depend stack configuration, temperature, and heat dissipation characteristics. Thermal machine provides critical insight for optimizing thermal management strategies and determined the most effective component layout and monitoring arrangements.							
Test Equipment	1. KSON THS-B4T-150 Chamber.						
Quantity Tested Minimum 1 Set							
Test Software	CPU Stress: Stress-ng GPU Stress: glmark2 LAN Speed Test: iPerf3						
Test Procedure	 Thermal Pre-Scan Measurement: Temperature Range: -20°C to 60°C Humidity Condition: 60% RH (when temperature exceeds 25°C) Actual Thermal Measurement Procedure: Identify the test points using the infrared thermal image and attach thermocouples to the identified hot spots. Place the Equipment Under Test (EUT) in the thermal chamber and configure the test temperature profile according to the specified requirements. Power on the EUT after closing the thermal chamber. Boot into Ubuntu 22.04.5 LTS and initiate a maximum power consumption and stress test. After running the test software continuously for 8 hours, record the peak temperature observed at each thermocouple measurement point. Power off both the thermal chamber and the EUT. Verify that the recorded temperature data for each component remains within its specified operating temperature range, as defined in the component specification or approval documents. 						
Test Diagram of Curves	Environment defines for 53 hours. Temp. (°C) 60 50 40 40 25 0.5 1.5 9.5 10.0 18.5 18.5 26.5 18.5 27.0 35.0 35.5 43.5 44.0 52.0 52.5 53.0 Time (hour)						

2-2. TEST RESULT

2-2-1. Temperature Cycle

Aging tests were performed on individual components across a range of temperature settings, under both maximum load and full load conditions, to evaluate thermal endurance and operational stability over time.

Test Temperature	Test Result
-20°C / 0%RH	PASS PASS
0°C / 0%RH	PASS
25°C / 60%RH	PASS
40°C / 60%RH	PASS
50°C / 60%RH	PASS
60°C / 60%RH	PAS5

PERFORMANCE TEST REPORT

NV300-1LS64-AMB

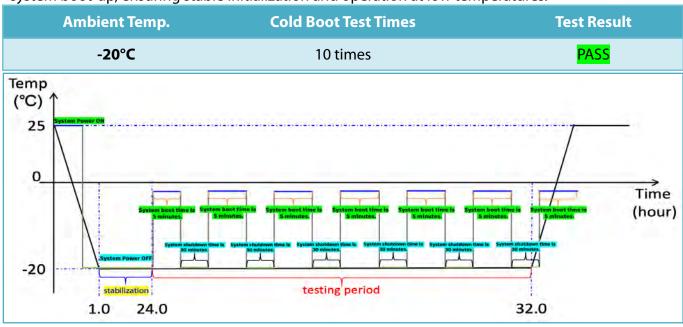
2-2-2. I/O Function

Confirm that the system specifications and all input/output (I/O) interfaces are correctly configured and functioning as intended, in accordance with the defined technical standards.

Item	Test Criteria				
X2 – HDMI	The HDMI output was verified to be working properly with a resolution of 3840 x 2160.	PASS			
X3 – USB 3.0	A PassMark USB 3.0 Loopback was connected for testing and was found to be functioning normally.	PASS			
X4 – 1.0GbE	Data transmission via connection to a 1.0Gbps LAN switch has been tested. The transfer speed meets the required standard with zero packet loss, confirming normal functionality.	PASS			
X5 – RS422	he two RS422 devices were successfully connected. Data transmission tests showed no packet loss, confirming normal operation.	PASS			

2-2-3. Low Temperature Power Cycle Test

Apply power to the system under a -20°C ambient condition and confirm successful system boot-up, ensuring stable initialization and operation at low temperatures.

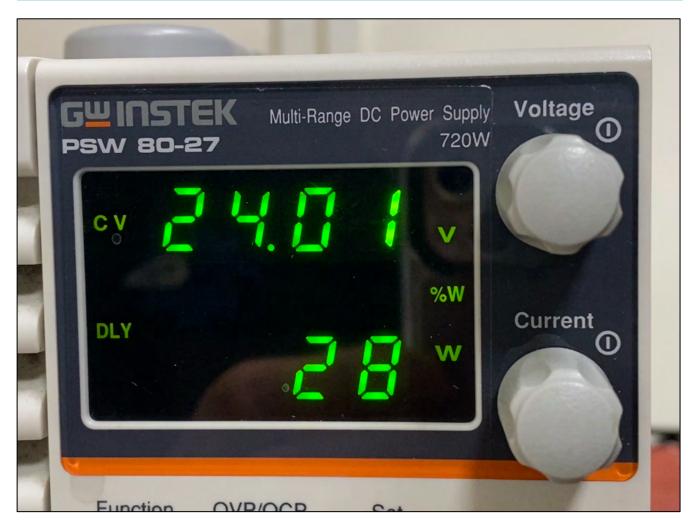






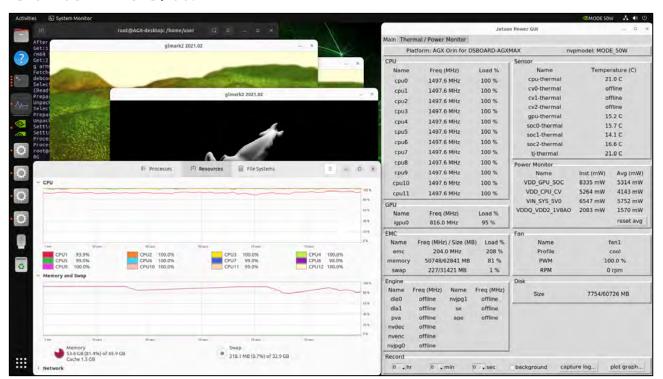
2-3. POWER CONSUMPTION

Voltage	Current	Wattage
12.0V	2.33A	28W
24.0V	1.67A	28W
30.0V	0.93A	28W



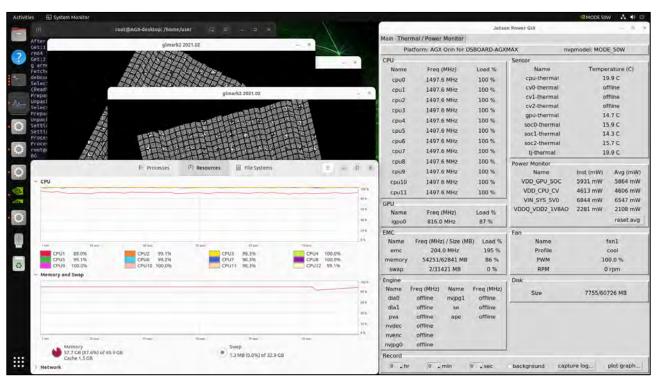
3. TEST PHOTO IN LAB





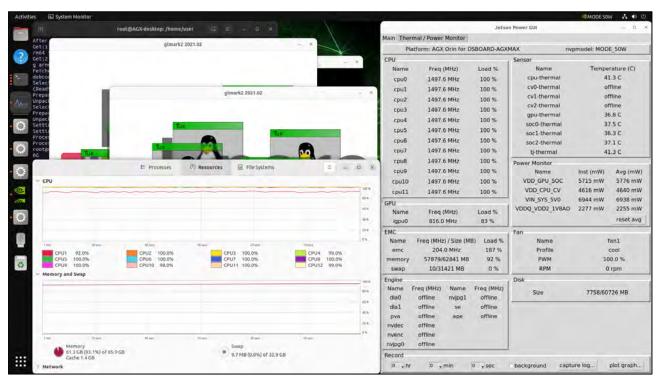


- Chamber in 0°C / 0%RH





- Chamber in 25°C / 60%RH

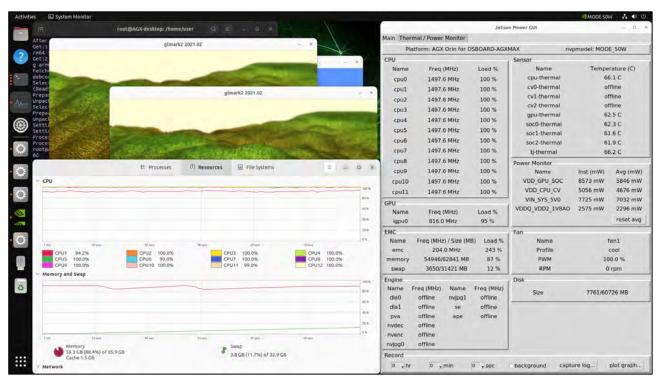




NV300-1LS64-AMB - Chamber in 40°C / 60%RH Main Thermal / Power Monitor Platform: AGX Orin for DSBOARD-AGXMAX nvpmodel: MODE 50W Name Load % Name Freq (MHz) 56.0 C 1497.6 MHz 100 % cpu0 cv0-thermal offline 1497.6 MHz glmark2 2021.02 1497.6 MHz 100 % cv2-thermal сриз 1497.6 MHz 100 % gpu-thermal soc0-thermal 51.7 C 1497.6 MHz cpu4 100 % 51.9 C 1497.6 MHz 100 % soc1-thermal 50.8 C сриб 1497.6 MHz 100 % 51.9 C soc2-thermal 1497.6 MHz cpu7 100 % tj-thermal 56.0 C cpu8 100 % E Processes (*) Resources (*) File Systems 1497.6 MHz 100 % VDD GPU SOC cpu10 1497.6 MHz 100 % 6160 mW 5787 mW VDD_CPU_CV 4620 mW 4640 mW cpul1 1497.6 MHz 100 % 7241 mW VIN SYS 5VO 6955 mW GPU VDDQ_VDD2_1V8AO Freq (MHz) Load % reset avg igpu0 816.0 MHz 90 % Name Freq (MHz) / Size (MB) Load % Name cool 100.0 % CPU4 99.0% CPU8 100.0% CPU12 99.0% CPUZ 100.0% CPU6 100.0% CPU10 100.0% CPU3 100.0% CPU7 98.0% CPU11 99.0% 58370/62841 MB PWM 93 % Freq (MHz) 7759/60726 MB Size dla0 dla1 offline offline nvjpg1 40 % pva nvdec offline nvenc offline nvjpg0 Memory 61.9 GB (93.9%) of 65.9 GB Cache 1.5 GB 9.4 MB (0.0%) of 32.9 GB :::

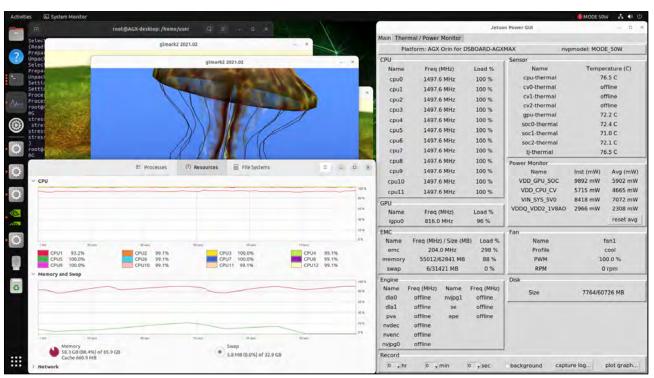


- Chamber in 50°C / 60%RH





- Chamber in 60°C / 60%RH



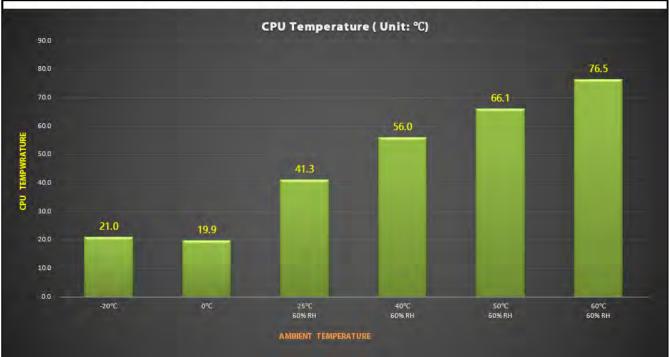


4. THERMAL TEST RESULT(-20°C ~ +60°C)

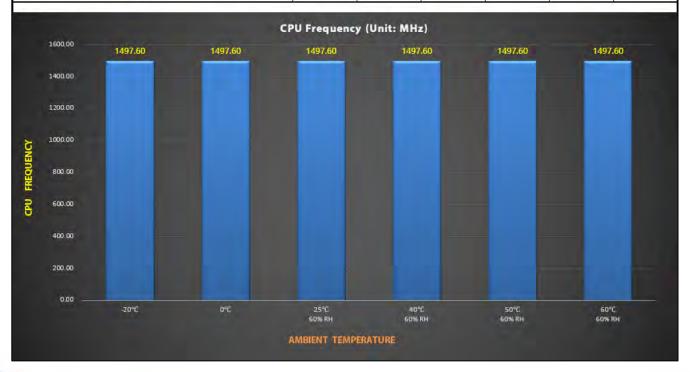
CPU & GPU Temperature/Frequency

Temperature Ambient Temp. Frequency	-20°C	0°C	25°C 60% RH	40℃ 60% RH	50℃ 60% RH	60℃ 60% RH
CPU Cores Max Temperature (Unit: °C)	21.0	19.9	41.3	56.0	66.1	76.5
CPU Cores Frequency (Unit: MHz)	1497.60	1497.60	1497.60	1497.60	1497.60	1497.60
Temperature Ambient Temp.	-20°C	0°C	25℃ 60% RH	40°C 60% RH	50℃ 60% RH	60℃ 60% RH
GPU Temperature (Unit: °C)	15.2	14.7	36.8	51.7	62.5	72.2

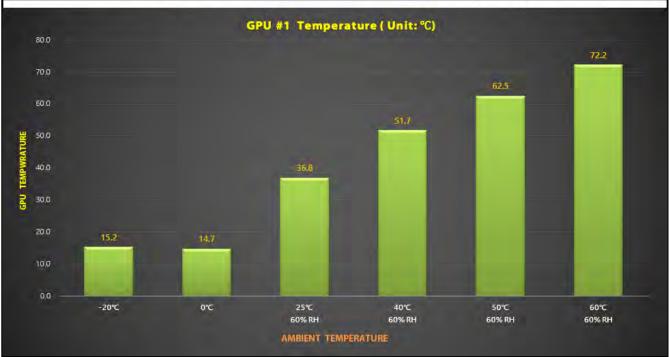
Core Temp Ambient Temp CPU Frequency	-20°C	0°C	25°C 60% RH	40°C 60% RH	50°C 60% RH	60°C 60% RH
CPU Cores Max Temperature (Unit: °C)	21.0	19.9	41.3	56.0	66.1	76.5



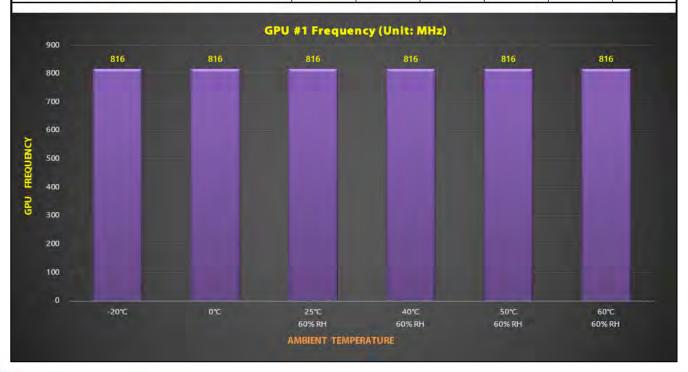
Core Temp Ambient Temp	-20°C	0°C	25°C 60% RH	40°C 60% RH	50°C 60% RH	60°C 60% RH
CPU Cores Frequency (Unit: MHz)	1497.60	1497.60	1497.60	1497.60	1497.60	1497.60



Core Temp Ambient Temp CPU Frequency	-20°C	0°C	25°C 60% RH	40°C 60% RH	50°C 60% RH	60°C 60% RH
GPU #1 Temperature (Unit: °C)	15.2	14.7	36.8	51.7	62.5	72.2

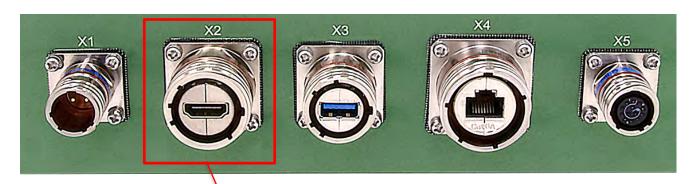


Core Temp CPU Frequency	-20°C	0°C	25°C 60% RH	40°C 60% RH	50°C 60% RH	60°C 60% RH
GPU Frequency (Unit: MHz)	816	816	816	816	816	816

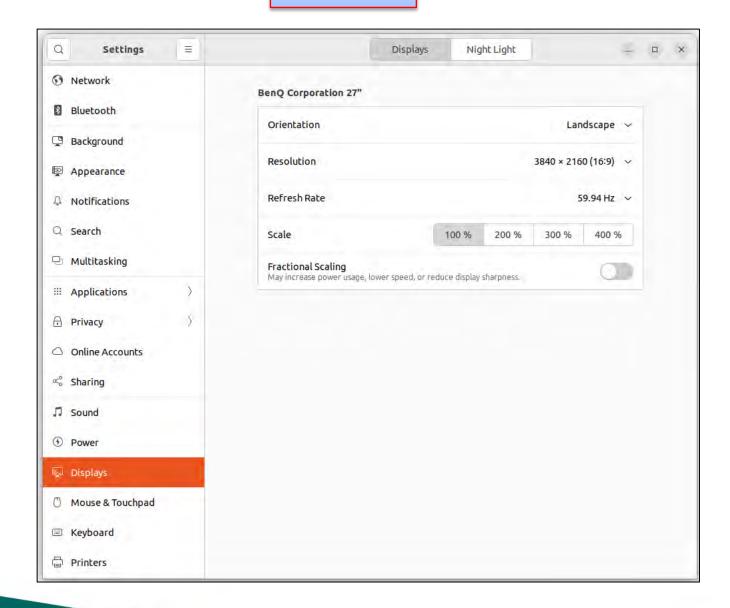


5. I/O FUNCTION TEST

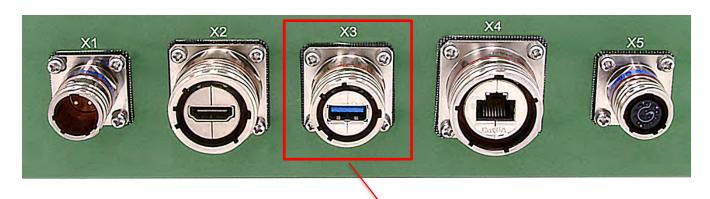
5-1. HDMI PORT



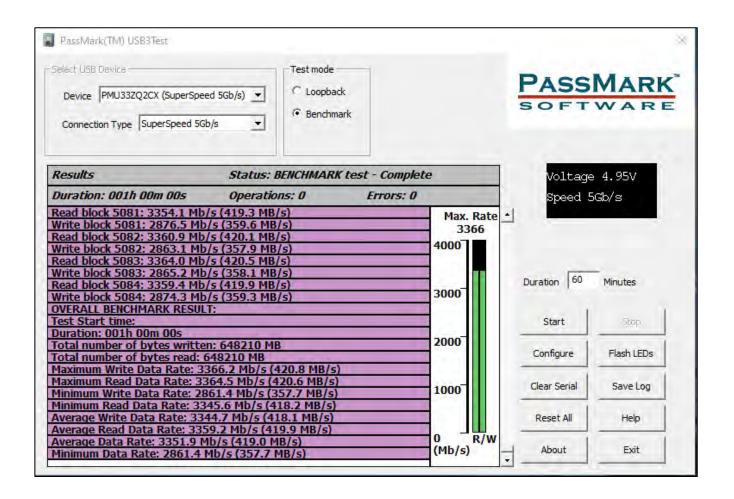
HDMI



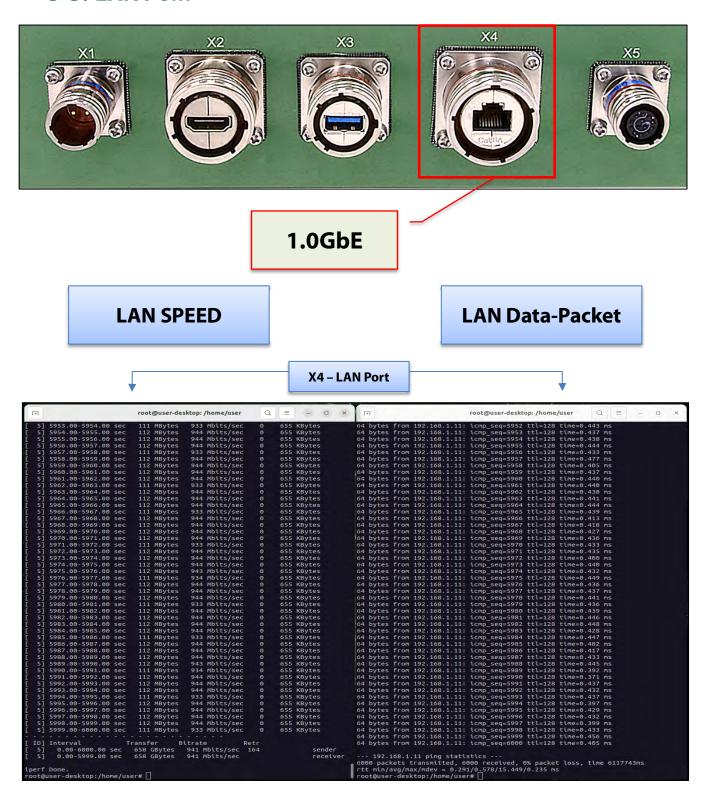
5-2. USB PORT



USB 3.0



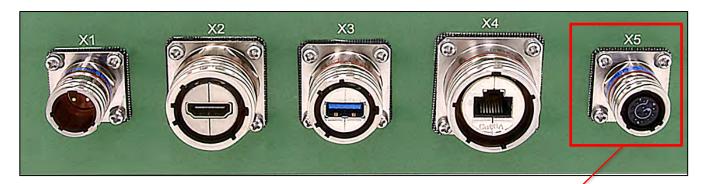
5-3. LAN PORT



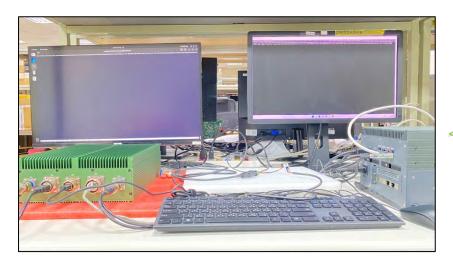
LAN Speed Test Result: Pass

LAN Data-Packet Test Result: 0 Lost (0% loss)

5-4. SERIAL PORT & USB PORT



This port provides RS-422 data transmission and the device's USB interface for the display connection.



RS-422 data transmission



The USB interface is used to transmit the side-panel function-key signals of the display.

----END-----